E7 SOLUTION PROPOSAL

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QUESTION:-1

Method 1 -

- 1. Calculating the number of edges of every bitmap using opency library.
- 2. Making histograms of the number of edges and checking the output for clustering purposes.
- 3. Making a tight fit box around the image of minimum area and calculating the difference of box area and the actual image.
- 4. Making histograms of the difference of area.
- 5. Using the two above features we will cluster the data using K means Clustering, Hierarchical clustering etc.
- 6. Evaluating the model using metrics like Davis- Bouildein index etc.

Method 2 - Using Pre Trained CNN features like VGG, ResNet, Inception

- 1. Extracting features from the above pretrained modules
- 2. Using tSNE & PCA reducing the dimensionality of data
- 3. Using K means clustering or other clustering method we will cluster the reduced data.
- 4. Evaluating the model using metrics like Davis- Bouildein index etc.

QUESTION :- 2 [Complexity Classification of Layouts]

1. Feature Extraction and Analysis:

- Analyze layout characteristics such as density, structural intricacy, and spatial arrangement.
- Develop features representing layout complexity, including edge density, area-to-perimeter ratio, and symmetry measures.

2. Criteria Definition:

- Establish criteria for classifying layouts into Low, Medium, or High complexity based on the extracted features.
- Define thresholds or rules for each complexity level (e.g., low complexity if edge density < threshold1, medium if threshold1 < edge density < threshold2, high otherwise).

3. Model Development:

- Train a classification model using machine learning techniques such as decision trees, random forests, or neural networks.
- Utilize labeled data to learn the relationship between layout features and complexity levels.

4. Evaluation:

- Evaluate the classification model's performance using metrics such as accuracy, precision, recall, and F1-score.
- Validate the model's effectiveness through cross-validation and testing with unseen data.

QUESTION:-3

- 1. Using the input parameters such as the dimensions (length, width) of the tight-fitting box, the layout area, and the permissible layout complexity we will use the similarity search algorithms to predict the most similar bitmap.
- 2. This will be based on the labels such as complexity and clustering done using the methods specified for part 1 and 2.
- 3. When we will get the input of layout by using custom similarity metrics we will give the closest bitmap among all the bitmaps.
- 4. One example of such metrics can be the percentage of area the tight-fitting box covers to the complete layout area, the shape of the layout area etc.

QUESTION:-4

Innovative Design Generation:

- 1. We can explore generative design algorithms like GANs and VAEs, and research if we can train them on the given dataset.
- 2. We can then use these trained models to generate new layout designs based on a predefined set of parameters instead of just predicting the closest design.
- 3. These parameters might include the maximum usable area, the complexity of the layout, number of edges, layout area etc.